

Vishay Siliconix

RoHS

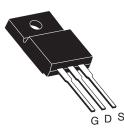
COMPLIANT

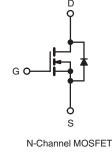


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	250			
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	1.1		
Q _g (Max.) (nC)	14			
Q _{gs} (nC)	2.7			
Q _{gd} (nC)	7.8			
Configuration	Single			

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI624GPbF
	SiHFI624G-E3
SnPb	IRFI624G
	SiHFI624G

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	250	v	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	I _D	3.4		
	VGS AL TO V	T _C = 100 °C		2.2	A	
Pulsed Drain Current ^a			I _{DM}	14		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Repetitive Avalanche Current ^a			I _{AR}	I _{AR} 3.4		
Repetitive Avalanche Energy ^a			E _{AR}	3.0	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D 30		W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
			Γ	1.1	N ⋅ m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 13 mH, $R_G = 25 \Omega$, $I_{AS} = 3.4$ A (see fig. 12).

c. $I_{SD} \leq 4.4$ A, $dI/dt \leq 90$ A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq 150 \ ^\circ C.$

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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PARAMETER	SYMBOL	ТҮР		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 65 - 4.1						
Maximum Junction-to-Case (Drain)	R _{thJC}				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted						
PARAMETER	SYMBOL	TES	ST CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 2	50 μA	250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	ce to 25 °C,	I _D = 1 mA	-	0.36	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$			-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} =	= 250 V, V _G s	s = 0 V	-	-	25	
	IDSS	V _{DS} = 200 V	/, V _{GS} = 0 V	, T _J = 125 °C	-	-	250	- μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 2.0 A ^b	-	-	1.1	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	2.0 A ^b	1.5	-	-	S
Dynamic							•	
Input Capacitance	C _{iss}	N 0.V			-	260	-	pF
Output Capacitance	C _{oss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	77	-		
Reverse Transfer Capacitance	C _{rss}			-	15	-		
Drain to Sink Capacitance	С			2	-	12	-	
Total Gate Charge	Qg			-	-	14	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \ V \qquad I_D = 4.4 \ A, \ V_{DS} = 200 \ V, \\ see \ fig. \ 6 \ and \ 13^b$		-	-		2.7
Gate-Drain Charge	Q _{gd}				-	-		7.8
Turn-On Delay Time	t _{d(on)}				-	7.0	-	
Rise Time	t _r		= 125 V, I _D =		-	13	-	1
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 18 \Omega, R_{D} = 28 \Omega,$ see fig. 10 ^b		-	20	-	ns	
Fall Time	t _f		Ū.		-	12	-	1
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	Ls			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s						•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.4	А	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	14		
Body Diode Voltage	V_{SD}	T _J = 25 °C	, I _S = 2.1 A,	$V_{GS} = 0 V^{b}$	-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C I			-	200	400	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 4.4 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	0.95	1.9	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by Ls and					vlsandl	5)

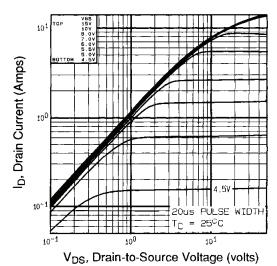
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



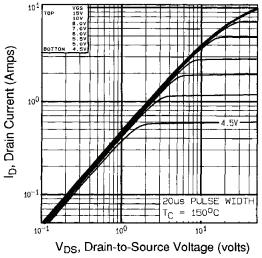
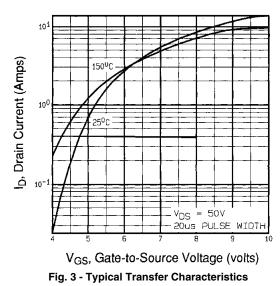


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C



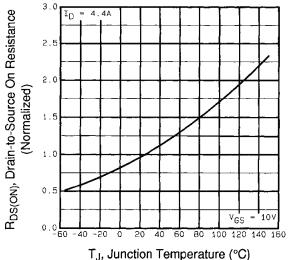
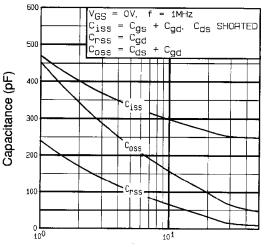
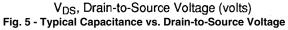


Fig. 4 - Normalized On-Resistance vs. Temperature

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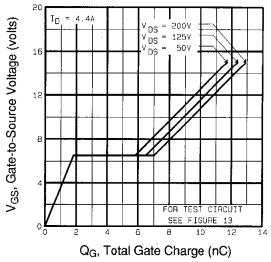
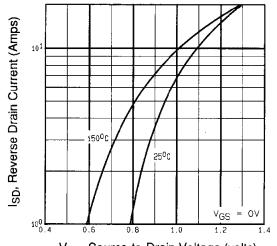
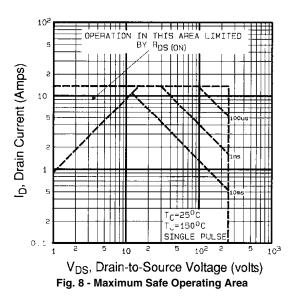


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage









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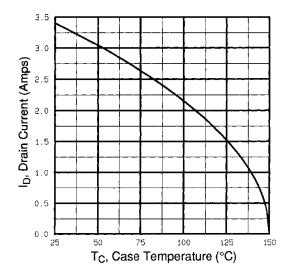


Fig. 9 - Maximum Drain Current vs. Case Temperature

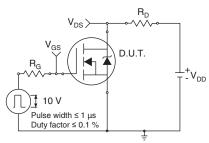


Fig. 10a - Switching Time Test Circuit

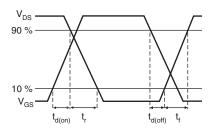
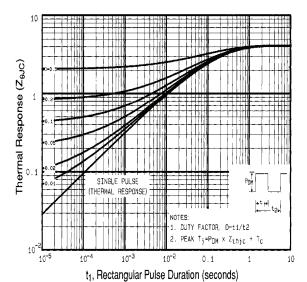
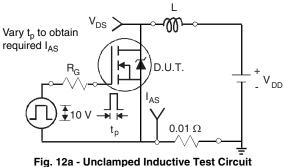


Fig. 10b - Switching Time Waveforms







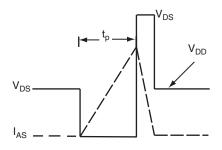
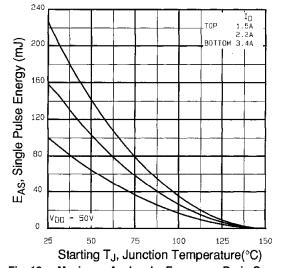
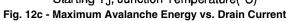


Fig. 12b - Unclamped Inductive Waveforms

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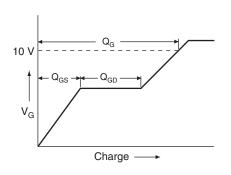
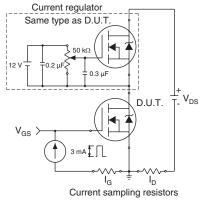
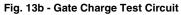
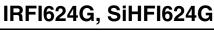


Fig. 13a - Basic Gate Charge Waveform

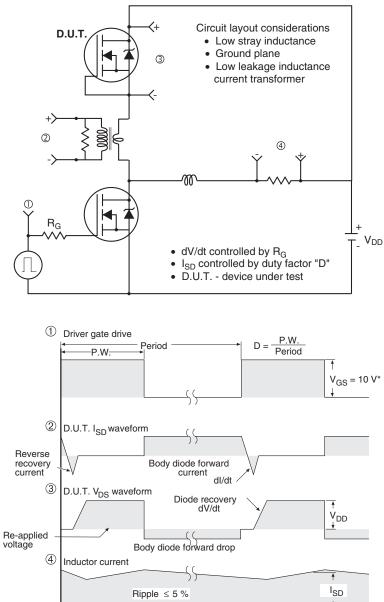






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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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